

## **Protected Power MOSFET**

2.6 A, 52 V, N-Channel, Logic Level, Clamped MOSFET w/ ESD Protection

# NCV8440, NCV8440A

#### **Features**

- Diode Clamp Between Gate and Source
- ESD Protection Human Body Model 5000 V
- Active Over-Voltage Gate to Drain Clamp
- Scalable to Lower or Higher R<sub>DS(on)</sub>
- Internal Series Gate Resistance
- These are Pb-Free Devices

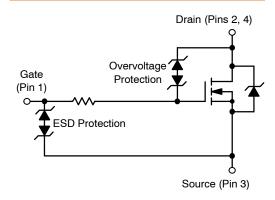
#### **Benefits**

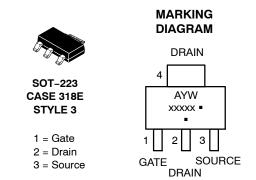
- High Energy Capability for Inductive Loads
- Low Switching Noise Generation

#### **Applications**

- Automotive and Industrial Markets:
   Solenoid Drivers, Lamp Drivers, Small Motor Drivers
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable

V <sub>DSS</sub> (Clamped)	R <sub>DS(ON)</sub> TYP	I <sub>D</sub> MAX	
52 V	95 mΩ @ 10 V	2.6 A	





A = Assembly Location Y = Year

W = Work Week xxxxx = V8440 or 8440A ■ = Pb-Free Package

(Note: Microdot may be in either location)

### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 8 of this data sheet.

## **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage Internally Clamped	$V_{DSS}$	52–59	V
Gate-to-Source Voltage - Continuous	V <sub>GS</sub>	±15	V
Drain Current - Continuous @ $T_A$ = 25°C - Single Pulse ( $t_p$ = 10 $\mu$ s) (Note 1)	I <sub>D</sub>	2.6 10	А
Total Power Dissipation @ T <sub>A</sub> = 25°C (Note 1)	$P_{D}$	1.69	W
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C
Single Pulse Drain–to–Source Avalanche Energy (V <sub>DD</sub> = 50 V, I <sub>D(pk)</sub> = 1.17 A, V <sub>GS</sub> = 10 V, L = 160 mH, R <sub>G</sub> = 25 $\Omega$ )	E <sub>AS</sub>	110	mJ
Load Dump Voltage (V <sub>GS</sub> = 0 and 10 V, R <sub>I</sub> = 2.0 $\Omega$ , R <sub>L</sub> = 9.0 $\Omega$ , td = 400 ms)	$V_{LD}$	60	V
Thermal Resistance,  Junction-to-Ambient (Note 1)  Junction-to-Ambient (Note 2)	$egin{array}{c} R_{ hetaJA} \ R_{ hetaJA} \end{array}$	74 169	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from Case for 10 Seconds	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. When surface mounted to a FR4 board using 1" pad size, (Cu area 1.127 in²).

2. When surface mounted to a FR4 board using minimum recommended pad size, (Cu area 0.412 in²).

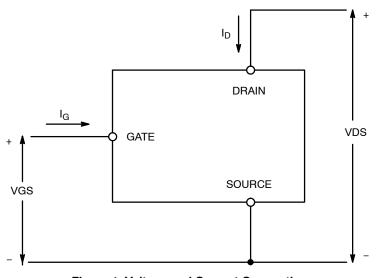


Figure 1. Voltage and Current Convention

## MOSFET ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

Charac	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage (Note 3) ( $V_{GS} = 0 \text{ V}, I_D = 1.0 \text{ mA}, T_J = 25^{\circ}\text{C}$ ) ( $V_{GS} = 0 \text{ V}, I_D = 1.0 \text{ mA}, T_J = -40^{\circ}\text{C}$ to 125°C) (Note 4) Temperature Coefficient (Negative)		V <sub>(BR)DSS</sub>	52 50.8	55 54 –9.3	59 59.5	V V mV/°C
Zero Gate Voltage Drain Current ( $V_{DS}$ = 40 V, $V_{GS}$ = 0 V) ( $V_{DS}$ = 40 V, $V_{GS}$ = 0 V, $T_{J}$ = 125°C)	(Note 4)	I <sub>DSS</sub>			10 25	μΑ
Gate-Body Leakage Current ( $V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V}$ ) ( $V_{GS} = \pm 14 \text{ V}, V_{DS} = 0 \text{ V}$ )	$(V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V})$			±35	±10	μΑ
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage (Note 3) $(V_{DS} = V_{GS}, \ I_D = 100 \ \mu A)$ Threshold Temperature Coefficient (Neg	V <sub>GS(th)</sub>	1.1	1.5 -4.1	1.9	V mV/°C	
Static Drain-to-Source On-Resistance (Note 3) ( $V_{GS} = 3.5 \text{ V}$ , $I_D = 0.6 \text{ A}$ ) ( $V_{GS} = 4.0 \text{ V}$ , $I_D = 1.5 \text{ A}$ ) ( $V_{GS} = 10 \text{ V}$ , $I_D = 2.6 \text{ A}$ )		R <sub>DS(on)</sub>		150 135 95	180 160 110	mΩ
Forward Transconductance (Note 3) (V <sub>I</sub>	<sub>DS</sub> = 15 V, I <sub>D</sub> = 2.6 A)	9FS		3.8		Mhos
DYNAMIC CHARACTERISTICS						
Input Capacitance		C <sub>iss</sub>		155		pF
Output Capacitance	Output Capacitance $V_{DS} = 35 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 10 \text{ kHz}$			60		
Transfer Capacitance	Fransfer Capacitance			25		
Input Capacitance		C <sub>iss</sub>		170		pF
Output Capacitance $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 10 \text{ kHz}$		C <sub>oss</sub>		70		
Transfer Capacitance		C <sub>rss</sub>		30		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 3. Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.
- 4. Not subject to production testing.
- 5. Switching characteristics are independent of operating junction temperatures.

## MOSFET ELECTRICAL CHARACTERISTICS ( $T_J = 25$ °C unless otherwise noted)

Characteristic			Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (No	ote 5)					
Turn-On Delay Time		t <sub>d(on)</sub>		375		ns
Rise Time	$V_{GS} = 4.5 \text{ V}, V_{DD} = 40 \text{ V},$	t <sub>r</sub>		1525		
Turn-Off Delay Time	$I_D = 2.6 \text{ A}, R_D = 15.4 \Omega$	t <sub>d(off)</sub>		1530		
Fall Time	7	t <sub>f</sub>		1160		
Turn-On Delay Time		t <sub>d(on)</sub>		325		ns
Rise Time	V <sub>GS</sub> = 4.5 V. V <sub>DD</sub> = 40 V.	t <sub>r</sub>		1275		
Turn-Off Delay Time	$V_{GS} = 4.5 \text{ V}, V_{DD} = 40 \text{ V},$ $I_{D} = 1.0 \text{ A}, R_{D} = 40 \Omega$	t <sub>d(off)</sub>		1860		
Fall Time		t <sub>f</sub>		1150		
Turn-On Delay Time		t <sub>d(on)</sub>		190		ns
Rise Time	V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 15 V,	t <sub>r</sub>		710		
Turn-Off Delay Time	$I_D = 2.6 \text{ A}, R_D = 5.8 \Omega$	t <sub>d(off)</sub>		2220		
Fall Time		t <sub>f</sub>		1180		
Gate Charge		Q <sub>T</sub>		4.5		nC
	$V_{GS} = 4.5 \text{ V}, V_{DS} = 40 \text{ V},$ $I_{D} = 2.6 \text{ A (Note 3)}$	Q <sub>1</sub>		0.9		
		$Q_2$		2.6		
Gate Charge		Q <sub>T</sub>		3.9		nC
	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 1.5 \text{ A (Note 3)}$	Q <sub>1</sub>		1.0		
	15 = 1.5 / (Note 6)	Q <sub>2</sub>		1.7		
SOURCE-DRAIN DIODE CHARACTE	RISTICS	•	•	•		
Forward On-Voltage	$I_S$ = 2.6 A, $V_{GS}$ = 0 V (Note 3) $I_S$ = 2.6 A, $V_{GS}$ = 0 V, $T_J$ = 125°C	V <sub>SD</sub>		0.81 0.66	1.5	V
Reverse Recovery Time		t <sub>rr</sub>		730		ns
	$I_S = 1.5 \text{ A}, V_{GS} = 0 \text{ V},$ $dI_S/dt = 100 \text{ A/}\mu\text{s} \text{ (Note 3)}$	t <sub>a</sub>		200		1
	αίζιαι – 100 / γμο (11010 0)	t <sub>b</sub>		530		
Reverse Recovery Stored Charge		Q <sub>RR</sub>		6.3		μC
ESD CHARACTERISTICS (Note 4)		•	•	•	•	
Electro-Static Discharge Capability	Human Body Model (HBM)	ESD	5000			V
	Machine Model (MM)	1	500			
			1			

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 3. Pulse Test: Pulse Width  $\leq\!300~\mu\text{s},$  Duty Cycle  $\leq\!2\%.$
- 4. Not subject to production testing.
- 5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL PERFORMANCE CURVES**

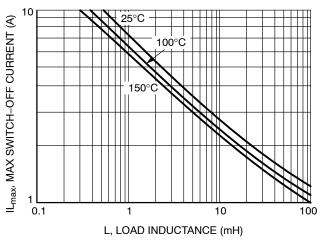


Figure 1. Single Pulse Maximum Switch-off Current vs. Load Inductance

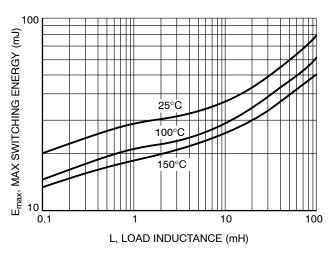


Figure 2. Single Pulse Maximum Switching Energy vs. Load Inductance

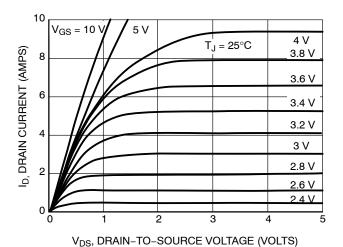


Figure 3. On-State Output Characteristics

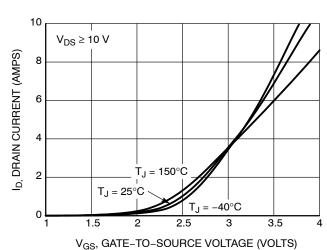


Figure 4. Transfer Characteristics

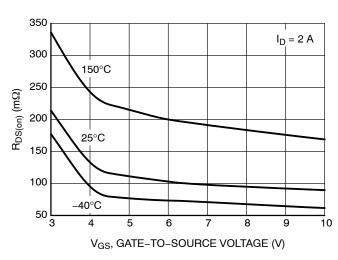


Figure 5. R<sub>DS(on)</sub> vs. Gate-Source Voltage

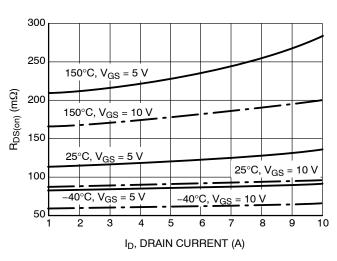


Figure 6. R<sub>DS(on)</sub> vs. Drain Current

#### **TYPICAL PERFORMANCE CURVES**

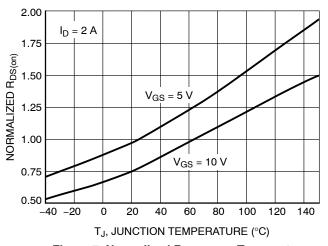


Figure 7. Normalized R<sub>DS(on)</sub> vs. Temperature

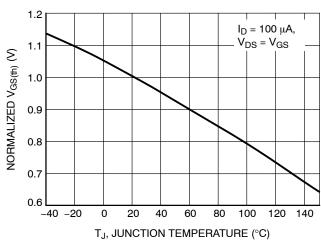


Figure 8. Normalized Threshold Voltage vs.
Temperature

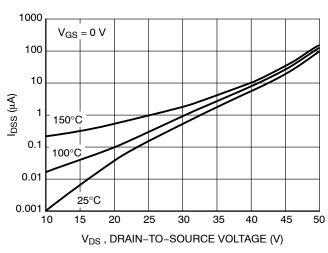


Figure 9. Drain-to-Source Leakage Current

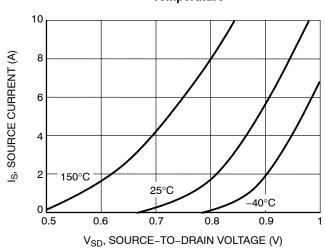


Figure 10. Source-Drain Diode Forward Characteristics

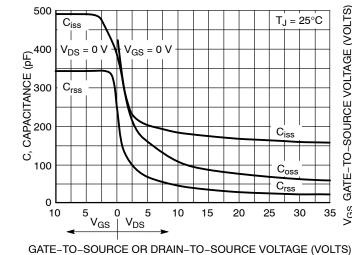


Figure 11. Capacitance Variation

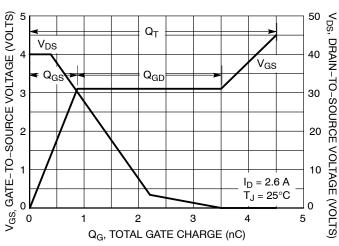


Figure 12. Gate-to-Source Voltage vs. Total Gate Charge

#### **TYPICAL PERFORMANCE CURVES**

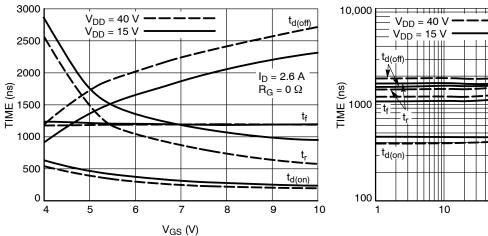


Figure 13. Resistive Load Switching Time vs.
Gate-Source Voltage

 $R_{G}\left(\Omega\right)$  Figure 14. Resistive Load Switching Time vs. Gate Resistance (V  $_{GS}$  = 5 V, I  $_{D}$  = 2.6 A)

100

10,000

1000

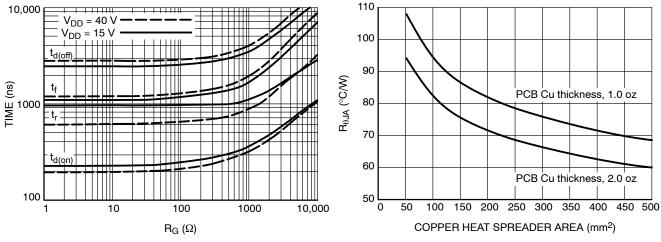


Figure 15. Resistive Load Switching Time vs. Gate Resistance ( $V_{GS} = 10 \text{ V}, I_D = 2.6 \text{ A}$ )

Figure 16.  $R_{\theta JA}$  vs. Copper Area

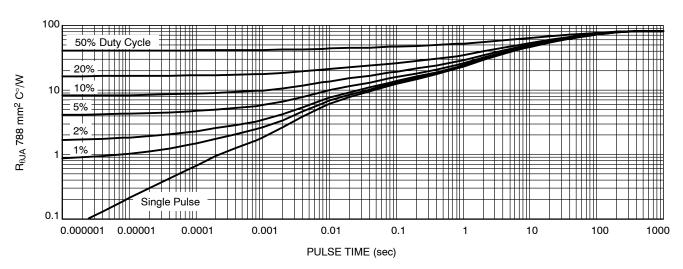


Figure 17. Transient Thermal Resistance

## **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NCV8440STT1G	SOT-223 (Pb-Free)	1000 / Tape & Reel
NCV8440ASTT1G	SOT-223 (Pb-Free)	1000 / Tape & Reel
NCV8440STT3G	SOT-223 (Pb-Free)	4000 / Tape & Reel
NCV8440ASTT3G	SOT-223 (Pb-Free)	4000 / Tape & Reel

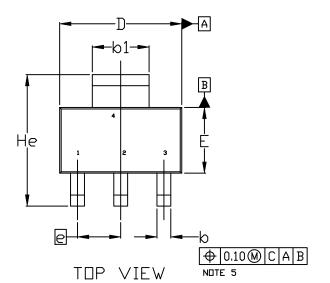
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

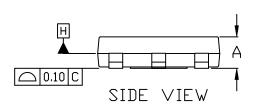


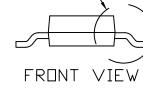


**SOT-223 (TO-261)** CASE 318E-04 ISSUE R

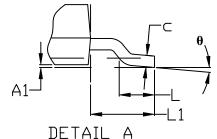
**DATE 02 OCT 2018** 







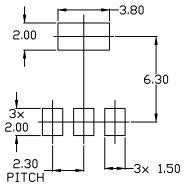
SEE DETAIL A



#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS D & E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS, MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.200MM PER SIDE.
- 4. DATUMS A AND B ARE DETERMINED AT DATUM H.
- 5. A1 IS DEFINED AS THE VERTICAL DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT OF THE PACKAGE BODY.
- 6. POSITIONAL TOLERANCE APPLIES TO DIMENSIONS 6 AND 61.

	MILLIMETERS			
DIM	MIN.	MAX.		
Α	1.50	1.63	1.75	
A1	0.02	0.06	0.10	
Ø	0.60	0.75	0.89	
b1	2.90	3.06	3.20	
U	0.24	0.29	0.35	
D	6.30	6.50	6.70	
E	3.30	3.50	3.70	
е		2.30 BSC	;	
L	0.20			
L1	1.50	1.75	2.00	
He	6.70	7.00	7.30	
θ	0°		10°	



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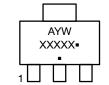
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**DATE 02 OCT 2018** 

STYLE 1: PIN 1. BASE 2. COLLECTOR 3. EMITTER 4. COLLECTOR	STYLE 2: PIN 1. ANODE 2. CATHODE 3. NC 4. CATHODE	STYLE 3: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN	STYLE 4: PIN 1. SOURCE 2. DRAIN 3. GATE 4. DRAIN	STYLE 5: PIN 1. DRAIN 2. GATE 3. SOURCE 4. GATE
STYLE 6: PIN 1. RETURN 2. INPUT 3. OUTPUT 4. INPUT	STYLE 7: PIN 1. ANODE 1 2. CATHODE 3. ANODE 2 4. CATHODE	4. DHAIN STYLE 8: CANCELLED	STYLE 9: PIN 1. INPUT 2. GROUND 3. LOGIC 4. GROUND	STYLE 10: PIN 1. CATHODE 2. ANODE 3. GATE 4. ANODE
STYLE 11: PIN 1. MT 1 2. MT 2 3. GATE 4. MT 2	STYLE 12: PIN 1. INPUT 2. OUTPUT 3. NC 4. OUTPUT	STYLE 13: PIN 1. GATE 2. COLLECTOR 3. EMITTER 4. COLLECTOR		

# GENERIC MARKING DIAGRAM\*



A = Assembly Location

Y = Year W = Work Week

XXXXX = Specific Device Code

■ = Pb-Free Package

(Note: Microdot may be in either location)
\*This information is generic. Please refer to
device data sheet for actual part marking.
Pb-Free indicator, "G" or microdot "•", may
or may not be present. Some products may
not follow the Generic Marking.

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